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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T.R.C.	5,598,285	1/1997	Kondo et al.	349	39	September 20, 1993
	5,838,037	11/1998	Masutani et al.	257	296	May 19, 1997
	5,946,060	8/1999	Nishiki et al.	349	48	June 3, 1997
	5,990,987	11/1999	Tanaka	349	43	November 17, 1998
	6,028,653	2/2000	Nishida	349	141	June 19, 1997
	6,097,454	8/2000	Zhang et al.	349	43	June 29, 1999
	5,745,207	4/1998	Asada et al.	349	141	November 27, 1996
	5,905,556	5/1999	Suzuki et al.	349	141	July 11, 1997
	5,946,066	8/1999	Lee et al.	349	141	June 25, 1998
	6,266,116 B1	7/2001	Ohta et al.	349	141	September 26, 1996

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
09-005764	1/1997	Japan	Abstract
09-073101	3/1997	Japan	Abstract
09-105908	4/1997	Japan	Abstract
09-101538	4/1997	Japan	Abstract

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

T.R.C.	R. Kieler et al.; "In-Plane Switching of Nematic Liquid Crystals"; Japan Display '92; pages 547-550
	M. Oh-e, et al.; "Principles and Characteristics of Electro-Optical Behaviour with In-Plane Switching Mode"; Asia Display '95; pages 577-580
	M. Ohta et al.; "Development of Super-TFT-LCDs with In-Plane Switching Display Mode"; Asia Display '95; pages 707-710
	S. Matsumoto et al.; "Display Characteristics of In-Plane Switching (IPS) LCDs and a Wide-Viewing-Angle 14.5-in. OPS TFT-LCD; Euro Display '96; pages 445-448
	H. Wakemoto et al.; "An Advanced In-Plane Switching Mode TFT-LCD"; SID 97 Digest; pages 929-932
	S.H. Lee et al.; "High-Transmittance, Wide-Viewing-Angle Nematic Liquid Crystal Display Controlled by Fringe-Field Switching; Asia Display '98; pages 371-374

EXAMINER

DATE CONSIDERED

03/17/03

\*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

\*\*English-language abstract provided.